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TEST REPORT
IEC 60825-1, 2nd Edition
Part 1: Equipment classification and requirements

Report Reference No.....:	171202538SHA-001
Date of issue.....:	2018-01-18
Total number of pages	17
CB Testing Laboratory.....:	Intertek Testing Services Shanghai Limited
Address.....:	Building No.86, 1198 Qinzhou Road (North), Shanghai 200233, China
Applicant's name.....:	Bandweaver Technology Limited
Address .....:	Lightbox G17, 111 Power Road, Chiswick, London, UK W4 5PY
Test specification:	
Standard.....:	IEC 60825-1:2007 (2nd Edition)
Test procedure .....:	Testing Report
Non-standard test method……..:	N/A
Test Report Form No.....:	IEC60825_1D
Test Report Form(s) Originator .....:	Intertek Semko AB
Master TRF .....:	Dated 2007-06

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Test item description .....:	Distributed Temperature Sensor
Trade Mark .....:	Bandweaver
Manufacturer .....:	Pinghu Bandweaver Technologies Co., Ltd
	2nd Floor East, Building 1, 669 Xinxing 1 Road, Economic Development Zone, Pinghu, Zhejiang Province, P. R. China
Model/Type reference.....:	Access
Ratings .....:	DC24V, 3.75A

Testing procedure and testing location:	
☒ **Testing Laboratory:**	Intertek Testing Services Shanghai Limited
Testing location/ address ..... :	Building No.86, 1198 Qinzhou Road (North), Shanghai 200233, China
Tested by (name + signature) ..... :	Jarree Jiang
Approved by (+ signature) ..... :	Justin Yu
☐ Testing procedure: TMP	
Tested by (name + signature) ..... :	
Approved by (+ signature) ..... :	
Testing location/ address ..... :	
☐ Testing procedure: WMT	
Tested by (name + signature) ..... :	
Witnessed by (+ signature) ..... :	
Approved by (+ signature) ..... :	
Testing location/ address ..... :	
☐ Testing procedure: SMT	
Tested by (name + signature) ..... :	
Approved by (+ signature) ..... :	
Supervised by (+ signature) ..... :	
Testing location/ address ..... :	
☐ Testing procedure: RMT	
Tested by (name + signature) ..... :	
Approved by (+ signature) ..... :	
Supervised by (+ signature) ..... :	
Testing location/ address ..... :	